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AMENDMENTS TO THE CLAIMS

Claims 1-45. (Canceled)

- 46. (Previously presented) An integrated circuit substrate comprising at least one buried conductor pattern provided within a monocrystalline substrate such that at least a portion of a top surface of said buried conductor pattern is below a top surface of said substrate and at least a portion of a bottom surface of said buried conductor pattern is above a bottom surface of said substrate, said at least one buried conductor pattern having a spherical pattern and forming at least a part of an interconnect between devices, and a conductive path extending from said buried conductor pattern to said devices.
- 47. (Previously presented) The integrated circuit of claim 46, further comprising a second buried conductor pattern having a pipe-shaped pattern.
- 48. (Previously presented) The integrated circuit of claim 46, further comprising a second buried conductor pattern having a plate-shaped pattern.

Claims 49-50 (Canceled).

- 51. (Previously presented) The integrated circuit of claim 46, wherein said at least one buried conductor pattern is formed of a material selected from the group consisting of copper, copper alloy, silver, silver alloy, gold, gold alloy, tungsten, tungsten alloy, aluminum and aluminum alloy.
- 52. (Original) The integrated circuit of claim 46, wherein said monocrystalline substrate is a silicon substrate.

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53. (Original) The integrated circuit of claim 46, wherein said monocrystalline substrate is a germanium substrate.

54. (Original) The integrated circuit of claim 46, wherein said monocrystalline substrate is a silicon-on-insulator substrate.

55. (Original) The integrated circuit of claim 46, wherein said monocrystalline substrate is a silicon-on-nothing substrate.

56. (Currently amended) A buried conductor pattern within a monocrystalline substrate, comprising:

at least one empty-spaced pattern in said monocrystalline substrate formed by annealing said substrate containing at least one hole drilled therein, said emptyspaced pattern having one of a sphere-shaped, plate-shaped, or pipe-shaped configuration; [[and]]

a conductive material filling said empty space pattern such that at least a portion of a top surface of said conductive material is below a top surface of said monocrystalline substrate and at least a portion of a bottom surface of said conductive material is above a bottom surface of said monocrystalline substrate, said buried conductor pattern forming at least a part of an interconnect between devices and being completely surrounded by monocrystalline material; and

a conductive path connecting said buried conductor pattern with the exterior of said monocrystalline substrate.

Claim 57 (Canceled).

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58. (Original) The buried conductor pattern of claim 56, wherein said empty-spaced pattern has a pipe-shaped configuration.

- 59. (Original) The buried conductor pattern of claim 56, wherein said empty-spaced pattern has a plate-shaped configuration.
- 60. (Original) The buried conductor pattern of claim 56, wherein said empty-spaced pattern has a sphere-shaped configuration.
 - 61. (Canceled)
 - 62. (Currently amended) A processor system comprising:
 - a processor; and

a circuit coupled to said processor, at least one of said circuit and processor comprising:

a conductive structure comprising a monocrystalline substrate having at least one empty space pattern formed by annealing said monocrystalline substrate having at least one hole drilled therein, said empty-spaced pattern having one of a sphere-shaped, plate-shaped, or pipe-shaped configuration; [[and]]

a conductive material filling said empty space pattern such that at least a portion of a top surface of said conductive material is below a top surface of said monocrystalline substrate and at least a portion of a bottom surface of said conductive material is above a bottom surface of said monocrystalline substrate, said conductive structure forming at least a part of an interconnect between devices and being completely surrounded by monocrystalline material; and

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a conductive path extending from said conductive structure to said top surface of said monocrystalline substrate.

- 63. (Previously presented) The processor based system of claim 62, wherein said empty-spaced pattern has a pipe-shaped configuration.
- 64. (Original) The processor system of claim 62, wherein said empty-spaced pattern has a plate-shaped configuration.
- 65. (Original) The processor system of claim 62, wherein said empty-spaced pattern has a sphere-shaped configuration.
 - 66. (Canceled)
- 67. (Original) The processor system of claim 62, wherein said circuit is a memory circuit.
- 68. (Original) The processor system of claim 62, wherein said circuit is a DRAM memory circuit.
- 69. (Original) The processor system of claim 62, wherein said circuit and said processor are integrated on same circuit.
- 70. (Original) The processor system of claim 62, wherein said processor comprises said conductive structure.
- 71. (Original) The processor system of claim 62, wherein said circuit comprises said conductive structure.
- 72. (Previously presented) An integrated circuit substrate comprising at least one buried conductor pattern provided within a monocrystalline substrate such that at

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least a portion of a top surface of said buried conductor pattern is below a top surface of said substrate and at least a portion of a bottom surface of said buried conductor pattern is above a bottom surface of said substrate, said at least one buried conductor pattern having a plate-shaped pattern and forming at least a part of an interconnect between devices, and a conductive path extending from said buried conductor pattern.

73. (Previously presented) The integrated circuit of claim 72, further comprising a second buried conductor pattern having a pipe-shaped pattern.

74. (Previously presented) The integrated circuit of claim 73, further comprising a third buried conductor pattern having a spherical pattern.

75. (Previously presented) An integrated circuit substrate comprising at least one buried conductor pattern provided within a monocrystalline substrate such that at least a portion of a top surface of said buried conductor pattern is below a top surface of said substrate and at least a portion of a bottom surface of said buried conductor pattern is above a bottom surface of said substrate, said at least one buried conductor pattern having a pipe-shaped pattern and forming at least a part of an interconnect between devices, and a conductive path extending from said buried conductor pattern.

76. (Previously presented) An integrated circuit substrate comprising first and second buried conductor patterns provided within a monocrystalline substrate such that at least a portion of a top surface of each of said buried conductor patterns is below a top surface of said substrate and at least a portion of a bottom surface of each of said buried conductor patterns is above a bottom surface of said substrate, said first and second buried conductive patterns forming at least a part of first and second interconnects between devices, respectively, wherein said first buried conductor pattern is located below said second buried conductor pattern and relative to said

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surface of said monocrystalline substrate, and a first conductive path extending from said first buried conductor pattern and a second conductive path extending from said second buried conductor pattern.

- 77. (Previously presented) The integrated circuit of claim 76, further comprising a third buried conductor pattern located below said first and second buried conductor patterns and relative to a surface of said monocrystalline substrate and a third conductive path extending from said third buried conductor pattern.
- 78. (Previously presented) The integrated circuit of claim 77, wherein one of said buried conductor patterns has a pipe-shaped pattern.
- 79. (Previously presented) The integrated circuit of claim 77, wherein one of said buried conductor patterns has a plate-shaped pattern.
- 80. (Previously presented) The integrated circuit of claim 77, wherein one of said buried conductor patterns has a spherical pattern.
- 81. (Previously presented) The integrated circuit of claim 77, wherein said buried conductor patterns are formed of a conductive material selected from the group consisting of copper, copper alloy, silver, silver alloy, gold, gold alloy, tungsten, tungsten alloy, aluminum and aluminum alloy.
- 82. (Withdrawn) A buried conductive structure provided within a semiconductor substrate, said buried conductive structure being formed by a method comprising the steps of:

forming at least one empty-spaced pattern beneath a surface of, and within a, semiconductor substrate, said empty-spaced pattern being surrounded by semiconductor material:

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forming at least one opening within said semiconductor substrate, said opening connecting a respective empty-spaced pattern with the exterior of said semiconductor substrate; and

forming a conductive material in said empty-spaced pattern and said opening.

- 83. (Withdrawn) The buried conductive structure of claim 82, wherein the act of forming said empty-spaced pattern further comprises the act of forming at least one hole within said semiconductor substrate and heat treating said substrate to form said empty-spaced pattern beneath said surface of said semiconductor material.
- 84. (Withdrawn) The buried conductive structure of claim 83, wherein said hole is a cylindrical hole.
- 85. (Withdrawn) The buried conductive structure of claim 82, wherein said empty-spaced pattern has a pipe-shaped configuration.
- 86. (Withdrawn) The buried conductive structure of claim 82, wherein said empty-spaced pattern has a spherical configuration.
- 87. (Withdrawn) The buried conductive structure of claim 82, wherein said empty-spaced pattern has a plate-shaped configuration.
- 88. (Withdrawn) The buried conductive structure of claim 82, wherein said at least one empty-spaced pattern comprises at least one pipe-shaped pattern and at least one plate-shape pattern.

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89. (Withdrawn) The buried conductive structure of claim 88, wherein said at least one pipe-shaped pattern and said at least one plate-shape pattern are formed simultaneously.

- 90. (Withdrawn) The buried conductive structure of claim 89, wherein said at least one pipe-shaped pattern and said at least one plate-shape pattern are formed sequentially and before said act of forming said conductive material.
- 91. (Withdrawn) The buried conductive structure of claim 82, wherein said conductive material is formed of a material selected from the group consisting of copper, copper alloy, silver, silver alloy, gold, gold alloy, tungsten, tungsten alloy, aluminum, and aluminum alloy.